

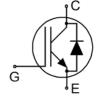
# TRENCHSTOP<sup>TM</sup> RC-Series for hard switching applications

## IGBT chip with monolithically integrated diode in packages offering space saving advantage

#### Features:

TRENCHSTOP<sup>TM</sup> Reverse Conducting (RC) technology for 600V applications offering:

- $\bullet$  Optimised  $V_{\text{CEsat}}$  and  $V_{\text{F}}$  for low conduction losses
- Smooth switching performance leading to low EMI levels
- Very tight parameter distribution
- Operating range of 1 to 20kHz
- Maximum junction temperature 175°C
- Short circuit capability of 5µs
- Best in class current versus package size performance
- Qualified according to JEDEC for target applications
- Complete product spectrum and PSpice Models: http://www.infineon.com/igbt/



**Applications:** 

Motor drives Discrete components and molded modules

Used for:

Chip Type	<b>V</b> <sub>CE</sub>	<i>I</i> <sub>Cn</sub>	Die Size	Package		
IGC05R60DE	600V	6A	2.21 x 2.19 mm <sup>2</sup>	sawn on foil		
Mechanical Paramet	ers					
Raster size			2.21	x 2.19		
Emitter pad size			see chip	$mm^2$		
Gate pad size			see chip	111111		
Area: total / active IGE	BT / active Dic	ode	4.84 / 2.2	219 / 0.477		
Thickness			70 μι			
Wafer size			200 m			
Max.possible chips per wafer			5775			
Passivation frontside		Photoimide				
Pad metal			32	200 nm AlSiCu		
Backside metal			Ni Ag -system			
Die bond			Electrically conductive epoxy glue and soft solder (temperature budget: 290°C for 1min. or 260°C for 1.5min			
Wire bond			Al, <250μm			
Reject ink dot size			Ø 0.65mm; max 1.2mm			
Storage environment  for original and sealed MBB bags  Storage environment  for open MBB bags  Ambient atmosphere air, Temperature 17°C < 6 month  Acc. to IEC62258-3: Atmosphere >99% Nitroge Humidity <25%RH, Temperature 17°C - 25°C		Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month				



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### **Maximum Ratings**

Parameter	Symbol	Value	Unit	
Collector-Emitter voltage, $T_{vj}$ =25 °C	V <sub>CE</sub>	600	V	
DC collector current, limited by $T_{\rm vjmax}$	I <sub>C</sub>	1)	А	
Pulsed collector current, $t_p$ limited by $T_{vj \text{ max}}$	$I_{c,puls}$	18	А	
Gate emitter voltage	V <sub>GE</sub>	±20	V	
Junction temperature range	$T_{\rm vj,max}$	-40+175	°C	
Operating junction temperature	$T_{vj,op,max}$	-40+175	°C	
Short circuit data $^{2)3)}$ $V_{GE} = 15V$ , $V_{CC} = 400V$ , $T_{vj} = 150$ °C	tsc	5	μs	
Safe operating area IGBT <sup>2)3)</sup>	$I_{C,max} = 12A$ , $V_{CE,max} = 600V$ , $T_{vj,op} \le T_{vj,op,max}$			
Safe operating area Diode <sup>2)</sup>	$I_{F,max} = 12A, V_{R,max} = 600V,$			
	$P_{max}$ =4.8 kW , $T_{vj,op} \leq T_{vj,op,max}$			

# Static Characteristics (tested on wafer), $T_{vj}$ =25 °C

Parameter	Symbol	Conditions	Value			Unit
- urumotor			min.	typ.	max.	
Collector-Emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{\rm GE}$ =0V , $I_{\rm C}$ = 0.2 mA	600			
Collector-Emitter saturation voltage	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =6A		1.65	2.1	V
Diode Forward Voltage	V <sub>F</sub>	V <sub>GE</sub> =0V, I <sub>F</sub> =6A		1.7	2.1	V
Gate-Emitter threshold voltage	$V_{\rm GE(th)}$	$I_{\rm C}$ =0.11mA , $V_{\rm GE}$ = $V_{\rm CE}$	4.3	5	5.7	
Zero gate voltage collector current	I <sub>CES</sub>	$V_{\text{CE}}$ =600V , $V_{\text{GE}}$ =0V			40	μA
Gate-Emitter leakage current	I <sub>GES</sub>	$V_{\text{CE}}$ =0V , $V_{\text{GE}}$ =20V			100	nA
Integrated gate resistor	$r_{\rm G}$			none		Ω

### Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter		Symbol	Conditions	Value			Unit
raiailletei		Syllibol	Conditions	min.	typ.	max.	Offic
Collector-Emitter saturation voltage	<i>T</i> <sub>vj</sub> =175 °C	V <sub>CEsat</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =6A		1.85		V
Input capacitance		Cies	$V_{CE}=25V$ ,		470		
Output capacitance		Coes	$V_{GE}=0V$ , $f=1MHz$		24		pF
Reverse transfer capacitance		C <sub>res</sub>	<i>T</i> <sub>vj</sub> =25 °C		14		

depending on thermal properties of assembly
 not subject to production test - verified by design/characterization

<sup>3)</sup> allowed number of short circuits: <1000; time between short circuits: >1s





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#### **Further Electrical Characteristic**

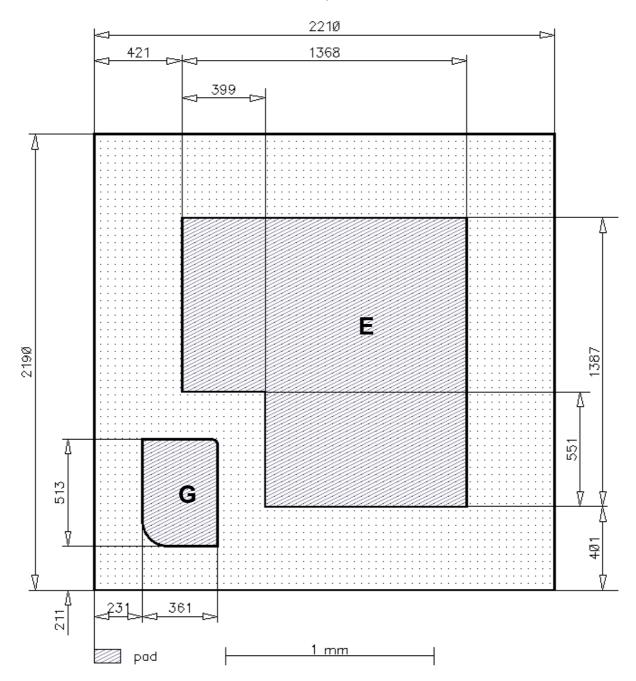
Switching characteristics and thermal properties are depending strongly on package design and mounting technology and can therefore not be specified for a bare die.

Further technical information about the performance of this chip in package PG-TO252-3 is given exemplarily at www.infineon.com/igbt. The chip qualification is independent of the qualification which is performed for the Discretes.

This chip data sheet refers to the device data sheet   INDODINOON   Nev. 2.2	This chip data sheet refers to the device data sheet	IKD06N60R	Rev. 2.2
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## **Chip Drawing**

Die-Size 2210 µm x 2190 um

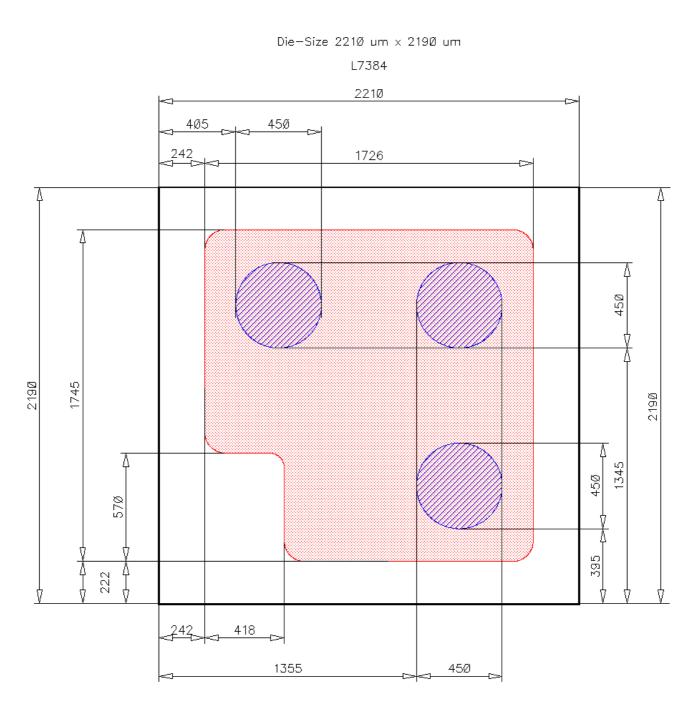


**E** = Emitter

**G** = Gate



### **Chip Drawing active areas**



Diode: Active Area
IGBT: Active Area





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Description
AQL 0,65 for visual inspection according to failure catalogue
Electrostatic Discharge Sensitive Device according to MIL-STD 883

#### **Revision History**

Version	Subjects (major changes since last revision)	Date

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